Search Notes				
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/813,967	TEGREENE, CLARENCE T.
Examiner	Art Unit
Andrew Wendell	2618

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

	RCH NOTES SEARCH STRATEGY	<u>()</u>
	DATE	EXMR
Duc Nguyen	5/16/2006	a.w.
IEEE Xplore	5/16/2006	a.w.
East Search	5/16/2006	a.W.
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